

Application/Control No.	Applicant(s)/Patent un Reexamination	Applicant(s)/Patent under Reexamination	
10/622,614	WATANABE, KENICH	11	
Examiner	Art Unit		

Alexander O. Williams

2826

SEARCHED			
Class	Subclass	Date	Examiner
257	e23.167	6/11/2007	AW
	e23.142		
	758,776		
	775,700		
	701,751		
	753,774		0
	762,763		
	765,767		
438	629,619		
	622		

INTERFERENCE SEARCHED			
Class	Class Subclass		Examiner
257	e23.167	6/11/2007	AW
	e23.142		
	758,776		
775,700,701,751,763,77 4,762,763,765,767; 438/629,619,622			

(INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
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Search Notes			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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